



Attorney Docket: 3319.3A (02US2)

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

James W. Overbeck

Serial No:

10/034,620

Filed:

December 27, 2001

For:

WIDE FIELD OF VIEW AND HIGH SPEED SCANNING MICROSCOPY

Examiner: T.Q. Nguyen

Art Unit: 2872

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## **RESPONSE**

In Response to the Office Action dated March 31, 2005, Applicant amends this application as follows: